

FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 36856.617	SERIAL NO. : Currently unknown
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA et al.	
	FILING DATE: Concurrently herewith	GROUP:

11002 U.S. PTO
10/054921
01/25/02

Reference Designation

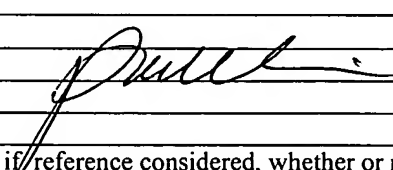
U.S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
pe	AA 5,906,950	05/1999	Keller et al.	438	719
	AB 5,932,950	08/1999	Yamada et al.	510	213
	AC 6,185,801	02/2001	Kadota et al.	29	25.35
	AD 5,497,726	03/1996	Shikata et al.	119	89
	AE 5,446,329	08/1995	Nakahata et al.	310	313
	AF 5,356,870	10/1994	Fujiwara et al.	505	329
FOREIGN PATENT DOCUMENTS					
	Document Number	Date	Country	Class	Filing Date Subclass if appropriate
pe	AG 2-189011 (With Abstracts)	07/1990	Japan	/	
	AH 5-299960 (With Abstracts)	11/1993	Japan		
	AI 6-268463 (With Abstracts)	09/1994	Japan		
	AJ 6-188664 (With Abstracts)	07/1994	Japan		
	AK 6-120759 (With Abstracts)	04/1994	Japan		
	AL 6-120416 (With Abstracts)	04/1994	Japan		
	AM 6-97760 (With Abstracts)	04/1994	Japan		
	AN 6-6160 (With Abstracts)	01/1994	Japan		
	A0				
OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)					
pe	AP R. SUBRAMANIAN et al.; "Production Trimming of SAW Devices Using CF ₄ Chemistry and its Effects on SAW Characteristics; 01/1996; IEEE Ultrasonics Symposium; PP 255-260				
pe	AR Takehiko UNO et al; "Frequency Trimming of SAW Devices by Sputter Etching"; NTT Electrical Communications Laboratories, Musashino, Tokyo 180; 12/1985; Proceedings of 6 th Symposium on Ultrasonic Electronics, Tokyo 1985; Japanese Journal of Applied Physics; Vol. 25 (1986) Supplement 25-1; PP. 145-147				
	AS				
	AT				
EXAMINER	<i>[Signature]</i>			DATE CONSIDERED	1/21/01
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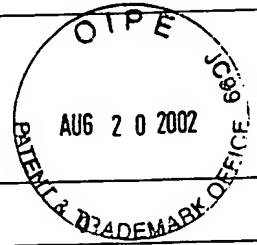
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U.S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA 5,343,107	08/1994	Shikata et al.	210	313
	AB 5,914,646	06/1999	Hashimoto	333	175
	AC 4,756,794	07/1988	Yoder	156	643
	AD 5,235,236	08/1993	Nakahata et al.	310	313
	AE 5,774,962	07/1998	Satoh et al.	29	25, 35
	AF 4,403,165	09/1983	Ballato et al.	310	313
FOREIGN PATENT DOCUMENTS					
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	AG				
	AH				
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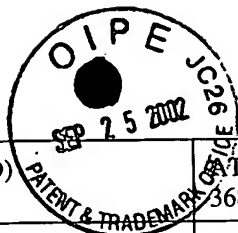
FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 36856.617	SERIAL NO. : 10/054,921
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA et al. COPY OF PAPERS ORIGINALLY FILED	
	FILING DATE: January 25, 2002	GROUP:



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Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA				
	AB				
	AC				
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	AF				
	FOREIGN PATENT DOCUMENTS				
	Document Number	Date	Country	Class	Filing Date Subclass if appropriate
<i>pat</i>	AG 61-20410	01/1986	Japan		
	AH				
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	AJ				
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	AL				
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OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)					
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EXAMINER	<i>[Signature]</i>			DATE CONSIDERED	<i>1/21/04</i>
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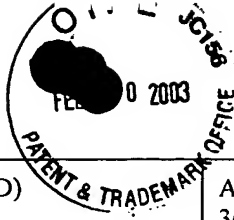


FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 36856.617	SERIAL NO. 10/054,921
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Eiichi TAKATA et al. SEP 30 2002 JC 3700 MAIL ROOM	
	FILING DATE: January 25, 2002	GROUP: 3729

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Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA				
	AB				
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	FOREIGN PATENT DOCUMENTS				
	Document Number	Date	Country	Class	Filing Date Subclass if appropriate
	AG 61-41446	09/1986	Japan		
	AH				
	AI				
	AJ				
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	AM				
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	AA				
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	AC				
	AD				
	AE				
	AF				
FOREIGN PATENT DOCUMENTS					
	Document Number	Date	Country	Class	Filing Date Subclass if appropriate
	AG 7-074573 (abstracts only)	03/1995	Japan		
	AH 8-139546 (abstract only)	05/1996	Japan		
	AI				
	AJ				
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OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)					
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EXAMINER				DATE CONSIDERED	1/21/03
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